


<b>Search Notes</b> 	<b>Application/Control No.</b>		<b>Applicant(s)/Patent under Reexamination</b>	
	10/676,195		FIKES ET AL.	
	<b>Examiner</b>		<b>Art Unit</b>	
	Tri V. Nguyen		3622	

SEARCHED			
Class	Subclass	Date	Examiner
705	14	3/28/2006	NVT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (PG-PUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB). SEE ATTACHED NOTES.	3/28/2006	NVT